

Search Notes

Application/Control No.

10/724,120

Examiner

David Y. Chung

Applicant(s)/Patent under
Reexamination

MIYAMURA ET AL.

Art Unit

2871


SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 349 | 158 | 9/19/2005 | DC |
| 349 | 58 | 9/19/2005 | DC |
| 349 | 149 | 9/19/2005 | DC |
| 349 | 150 | 9/19/2005 | DC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| same | same | 9/19/2005 | DC |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| Test search class 349, subclasses 58,149-152, 158-see search printout | 9/19/2005 | DC |
| PBPUB text search class 349 (claims only)-see search printout | 9/19/2005 | DC |
| Consulted Ken Parker  | 9/19/2005 | DC |
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